

Simulation of Transverse Instabilities in the NSLS II Storage Ring

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Simulation of Transverse Instabilities in the NSLS-II Storage Ring*

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Abstract

We have carried out computer simulations using MATLAB to study the transverse coupled-mode instability (TMCI) in the proposed NSLS-II storage ring. Our calculations have been performed using transverse short-range wakefields describing: a broad-band resonator; a resistive wall with normal surface impedance; and a chamber wall with extreme anomalous skin effect. We have considered: (1) the ring with a single-frequency RF system for which the equilibrium longitudinal bunch distribution is Gaussian; and (2) the ring with a third harmonic (Landau) cavity included to lengthen the bunch. Based on current NSLS-II design parameters, we report estimates of the TMCI threshold behavior. All of our results for the instability threshold (at zero chromaticity) are consistent (to about $\pm\,30\%$) with the simple relation

$$\frac{e^2 N_e^{th} \beta_y}{4\pi \gamma m c^2 v_s} \kappa_{\perp} \cong 0.7,$$

where κ_{\perp} is the transverse kick factor, N_e^{th} is the number of electrons in the bunch at threshold, β_y is the vertical betafunction at the impedance, and γmc^2 is the electron energy. For a single-frequency RF system, ν_s is the synchrotron tune, while for a Landau cavity, ν_s is the synchrotron tune of an electron with synchrotron amplitude equal to the rms bunch length.

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1. Introduction

In this note, we describe computer simulations using MATLAB to study transverse instabilities in the proposed NSLS-II storage ring. In order to investigate the single-bunch transverse coupled mode instability (TMCI) [1-8], we have incorporated transverse short-range wakefields [9,10] describing: (1) a broad-band resonator; (2) a resistive wall with normal surface impedance; and (3) a resistive wall with extreme anomalous skin effect. To facilitate study of coupled bunch instabilities, we have included normal and extreme-anomalous long-range resistive wall wakefields coupling different bunches via their transverse center of mass motion. Of special concern in this study are the wakefields arising from warm and superconducting small-gap undulators which are the primary sources of radiation for NSLS-II.

The program provides a description of instabilities in the cases: (1) when the ring has a single-frequency RF system and the equilibrium longitudinal bunch distribution is Gaussian; (2) when there is a higher harmonic (Landau) cavity [11] included to lengthen the bunch. Based on current NSLS-II design parameters, we report estimates of the TMCI threshold behavior. In the case of a broad-band resonator, we have checked that our results are in reasonable agreement with the frequency-domain code MOSES [4].

2. Equations of Motion

We consider the motion of n_b bunches, each comprised of n_p macroparticles, over n_r revolutions around the ring. The integrated effect of the wakefield is applied to the beam once per revolution. We denote the revolution period T_0 , angular revolution frequency $\omega_0 = 2\pi/T_0$, momentum compaction α , synchrotron oscillation tune $v_s = \omega_s/\omega_0$, vertical betatron tune of the synchronous particle v_{0y} , vertical chromaticity ξ_y , and the vertical beta-function at the point of wakefield interaction β_y . We introduce the revolution number $i=1,\ldots,n_r$, the bunch number, $j=1,\ldots,n_b$, and the macroparticle number $k=1,\ldots,n_p$. For the k^{th} macroparticle in the j^{th} bunch on the i^{th} revolution: the temporal deviation from the synchronous particle is $\tau_i(j,k)$ (positive indicates the macroparticle is in front of the synchronous particle); the fractional energy deviation is

 $\varepsilon_i(j,k)$; the vertical displacement is $y_i(j,k)$; the vertical angle is $p_i(j,k) = y_i'(j,k)$; and the vertical betatron tune is $v_{y,i}(j,k)$.

The transverse wakefield is denoted $w_{\perp}(s)$. Electron "1" with vertical displacement y_1 induces a change in vertical angle Δy_2 'of electron "2" a distance s behind the first, while traveling a distance $\Delta \ell$ on the ring orbit, where

$$\Delta y_2' = \frac{e^2 w_\perp(z) \Delta \ell}{\gamma m c^2} y_1. \tag{2.1}$$

We shall write the transverse wake in the form

$$W_{\perp}(s)\Delta \ell = W_0 f(s), \tag{2.2}$$

where f(s) is a dimensionless function. We define the dimensionless strength parameter,

$$Y = \frac{e^2 N_e \beta_y W_0}{8 \gamma m c^2 v_s}, \qquad (2.3)$$

with N_e being the number of electrons in a bunch. The number of electrons per macroparticle is N_e/n_p .

In the case of a single frequency RF system, the equations of motion are given by:

$$\varepsilon_{i+1}(j,k) = \varepsilon_i(j,k) + \frac{(2\pi v_s)^2}{\alpha T_0} \tau_i(j,k)$$
(2.4)

$$\tau_{i+1}(j,k) = \tau_i(j,k) - \alpha T_0 \varepsilon_{i+1}(j,k) \tag{2.5}$$

$$v_{y,i}(j,k) = v_{0y} + \xi \,\varepsilon_i(j,k) \tag{2.6}$$

$$y_{i+1}(j,k) = y_i(j,k)\cos[2\pi v_{y,i}(j,k)] + p_i(j,k)\beta_y \sin[2\pi v_{y,i}(j,k)]$$
(2.7)

$$p_{i+1}(j,k) = -y_{i}(j,k) \frac{1}{\beta_{y}} \sin[2\pi v_{y,i}(j,k)] + p_{i}(j,k) \cos[2\pi v_{y,i}(j,k)]$$

$$+ \frac{8v_{s} Y}{n_{p} \beta_{y}} \sum_{k'=1}^{n_{p}} y_{i}(j,k') f[c \tau_{i}(j,k') - c \tau_{i}(j,k)]$$

$$+ \frac{8v_{s} Y}{n_{p} \beta_{y}} \sum_{m=1}^{j-1} \bar{y}_{i}(ij-m) f\left[\frac{mcT_{0}}{n_{b}}\right].$$
(2.8)

Here, we have defined

$$ij = n_b(i-1) + j \tag{2.9}$$

and

$$\bar{y}(ij) = \frac{1}{n_p} \sum_{k=1}^{n_p} y_i(j,k). \tag{2.10a}$$

Initial values are determined from a Gaussian random number generator: temporal displacements $\tau_0(j,k)$ have standard deviation σ_t ; energy deviations $\varepsilon_0(j,k)$ have standard deviation $\sigma_\varepsilon = v_s \, \omega_0 \sigma_t / \alpha$; vertical displacements $y_0(j,k)$ have standard deviation $\sigma_y = \sqrt{\beta_y \, \varepsilon_y}$; and the vertical angular deviations $p_0(j,k)$ have standard deviation $\sigma_y' = \sqrt{\varepsilon_y / \beta_y}$.

While tracking the particles, for each bunch we save the values of the center of mass displacement, $\bar{y}(ij)$, and the rms deviation $y_{rms}(ij)$ of the electrons from the center of mass, where

$$y_{rms}(ij) = \sqrt{\frac{1}{n_p} \sum_{k=1}^{n_p} \left[y_i(j,k) - \bar{y}(ij) \right]^2}$$
 (2.10b)

We carry out a fast Fourier transform of the center of mass displacements and plot the resulting spectral amplitudes in the region near the betatron sidebands.

For a resonator [10], with transverse shunt impedance R_{\perp} (ohm/m), quality factor Q_{\perp} and resonant frequency $\omega_r = k_r c$,

$$f^{res}(s) = \exp\left[-\frac{k_r s}{2Q_\perp}\right] \sin\left[k_r s \sqrt{1 - \frac{1}{4Q_\perp^2}}\right], \qquad (2.11)$$

and

$$W_0^{res} = \frac{\omega_r R_{\perp}}{\sqrt{Q_{\perp}^2 - \frac{1}{4}}}, \quad Y^{res} = \frac{e^2 N_e \beta_y W_0^{res}}{8 \gamma m c^2 v_s}.$$
 (2.12)

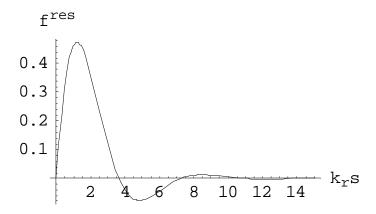


Figure 1. Shape of wakefield for broadband resonator with $Q_{\perp} = 1$.

For the normal transverse resistive wall wakefield [12] of a warm circular tube of length L, radius b and conductivity σ ,

$$f^{rw}(s) = \frac{4}{3}e^{-z/s_0} \left(-\cos\left(\frac{s\sqrt{3}}{s_0}\right) + \sqrt{3}\sin\left(\frac{s\sqrt{3}}{s_0}\right) \right) + \frac{16\sqrt{2}}{\pi} \int_0^\infty \frac{dx \, e^{-x^2s/s_0}}{x^6 + 8}, \qquad (2.13)$$

where

$$s_0 = \left(\frac{2b^2}{Z_0 \sigma}\right)^{1/3} \tag{2.14}$$

and

$$W_0^{rw} = \frac{cZ_0}{4\pi} \frac{2s_0 L}{b^4}, \qquad Y^{rw} = \frac{e^2 N_e \beta_y W_0^{rw}}{8\gamma mc^2 v_s} \quad . \tag{2.15}$$

To speed calculations, we use the approximation

$$f^{rw}(s) \cong \frac{4}{3}e^{-z/s_0} \left(-\cos\left(\frac{s\sqrt{3}}{s_0}\right) + \sqrt{3}\sin\left(\frac{s\sqrt{3}}{s_0}\right) \right) + \frac{1}{\sqrt{2\pi}} \frac{1}{\left[a^p + \left(s/4s_0\right)^{p/2}\right]^{1/p}}$$
 (2.16)

with

$$a = \frac{3}{4\sqrt{2\pi}}$$
, $p = 2.7$. (2.17)

For $s \gg s_0$,

$$f^{rw}(s) \approx \sqrt{\frac{2s_0}{\pi s}} . {2.18}$$

For a superconducting circular tube the wakefield [13] is determined by the extreme anomalous skin effect and

$$f^{ease}(s) = e^{-z/s_0} \left(\frac{3(-3+\sqrt{5})}{5} \cos(\sqrt{5+2\sqrt{5}} s/s_a) + \frac{3(-1+\sqrt{5})\sqrt{2(5+\sqrt{5})}}{10} \sin(\sqrt{5+2\sqrt{5}} s/s_a) \right) + \frac{3\sqrt{3}(-1+\sqrt{5})}{10\pi} \int_0^\infty dx \frac{\exp[-4(s/s_a)x^{3/5}/(-1+\sqrt{5})]}{x^{3/5}(1+x+x^2)}$$
(2.19)

where we define

$$s_a = \frac{(2\sqrt{3}/\pi)^{1/5}}{2\sin(\pi/10)} \left(\frac{b^3}{\sigma \ell \, ratio \, Z_0}\right)^{1/5} \,, \tag{2.20}$$

and

$$W_0^{ease} = \frac{cZ_0}{4\pi} \frac{2s_a L}{b^4}, \quad Y^{ease} = \frac{e^2 N_e \beta_y W_0^{ease}}{8\gamma mc^2 v_s}.$$
 (2.21)

To increase the speed of calculation, we use the approximation

$$f^{ease}(s) = e^{-z/s_0} \left(\frac{3(-3+\sqrt{5})}{5} \cos\left(\sqrt{5+2\sqrt{5}} s/s_a \right) + \frac{3(-1+\sqrt{5})\sqrt{2(5+\sqrt{5})}}{10} \sin\left(\sqrt{5+2\sqrt{5}} s/s_a \right) \right) + \frac{1}{\Gamma(1/3)} \frac{1}{\sqrt{a^2 + (d s/s_a)^{4/3}}}$$

(2.22)

with

$$a = \frac{10}{-6(-3+\sqrt{5})\Gamma(1/3)} \qquad d = \frac{4}{(-1+\sqrt{5})^{5/2}}.$$
 (2.23)

For $z \gg s_a$,

$$f^{ease}(s) \approx \frac{\left(-1 + \sqrt{5}\right)^{5/3}}{\Gamma(1/3)} \left(\frac{s_a}{4s}\right)^{2/3} = \eta \left(\frac{s_a}{s}\right)^{2/3}.$$
 (2.24)

where

$$\eta = \frac{4}{\Gamma(1/3)} \left(\sin(\pi/10) \right)^{5/3} = 0.21. \tag{2.25}$$

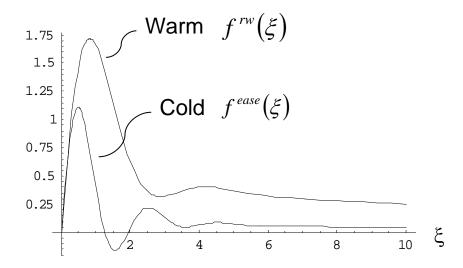


Figure 2. Comparison of shape functions for normal resistive wall wakefield (warm, $\xi = s/s_0$) and wakefield for extreme anomalous skin effect (cold, $\xi = s/s_a$).

3. Threshold Condition for Transverse Coupled Mode Instability

The simulations reported in the following sections, support the use of a simple approximation to estimate the threshold of the transverse mode coupling instability. If the center of mass of an electron bunch containing N_e electrons has transverse displacement y_{cm} from the axis, the transverse angular kick experienced by its center of mass is given by

$$y_{cm}' = \frac{e^2 N_e}{\gamma m c^2} y_{cm} \kappa_{\perp} , \qquad (3.1)$$

where the transverse kick factor $\kappa_{\scriptscriptstyle \perp}$ is expressed in terms of the wake field by

$$\kappa_{\perp} = \int_{-\infty}^{\infty} ds \int_{-\infty}^{s} ds' F(s) F(s') w_{\perp}(s-s') \Delta \ell , \qquad (3.2)$$

and F(s) is the normalized bunch density. The kick factor can also be determined in terms of the transverse impedance via

$$\kappa_{\perp} = \frac{c}{\pi} \int_{0}^{\infty} dk \left| \tilde{F}(k) \right|^{2} \operatorname{Im} Z_{\perp}(k), \tag{3.3}$$

where $\tilde{F}(k)$ is the Fourier transform of the bunch density normalized by $\tilde{F}(0) = 1$.

Let us define an average transverse coherent tune shift (divided by the synchrotron tune v_s) via

$$\left(\frac{\Delta v_y}{v_s}\right)^{av} \equiv \frac{e^2 N_e \beta_y}{4\pi \gamma m c^2 v_s} \kappa_\perp = \frac{2}{\pi} \frac{Y}{W_0} \kappa_\perp.$$
(3.4)

For the fundamental RF system, our simulations show that the threshold occurs when $(\Delta v_y/v_s)^{av}$ has a value between 0.45 and 1. Therefore to an accuracy of about $\pm 30\%$, the threshold is determined by

$$\frac{e^2 N_e \beta_y}{4\pi \gamma m c^2 v_s} \kappa_{\perp} = 0.7.$$
 (3.5)

We have confirmed this by simulations using wakefields corresponding to a broad-band resonator, resistive wall and extreme anomalous skin effect. It is reasonable to expect that this approximation will be useful for more general wakefields.

The kick factor corresponding to a resonant wakefield can be approximated in the two limits $k_r \sigma_s \ll 1$ and $k_r \sigma_s \gg 1$. From Eq. (3.2), one finds

$$\kappa_{\perp}^{res} \cong \int_{-\infty}^{\infty} ds \int_{-\infty}^{s} ds' F(s) F(s') (s-s') w_{\perp}(0+) \Delta \ell, \quad (k_r \sigma_s \ll 1)$$
(3.6)

and from Eq. (3.3),

$$\kappa_{\perp}^{res} \cong \frac{c}{\pi} \int_{0}^{\infty} dk \left| \tilde{F}(k) \right|^{2} \operatorname{Im} Z_{\perp}(0) = c \operatorname{Im} Z_{\perp}(0) \int_{-\infty}^{\infty} ds F^{2}(s) \qquad (k_{r}\sigma_{s} >> 1)$$
 (3.7)

For a ring with only the fundamental RF, the longitudinal bunch

distribution $F(s) = \frac{1}{\sqrt{2\pi} \sigma_s} \exp\left(-\frac{s^2}{2\sigma_s^2}\right)$. It then follows from Eqs. (3.6) that

$$\kappa_{\perp}^{res} \cong \frac{1}{\sqrt{\pi}} \frac{c R_{\perp}}{Q_{\perp}} \left(k_r^2 \sigma_s \right) \qquad (k_r \sigma_s \ll 1)$$
 (3.8)

and frm (3.7) that

$$\kappa_{\perp}^{res} \cong \frac{c}{2\sqrt{\pi} \,\sigma_s} \frac{R_{\perp}}{Q_{\perp}} \qquad (k_r \sigma_s >> 1) \tag{3.9}$$

We see that when $k_r \sigma_s << 1$, the kick factor increases linearly with bunch length and quadratically with frequency. When $k_r \sigma_s >> 1$, the kick factor is inversely proportional to bunch length and independent of frequency.

For the resistive wall wakefield, we use Eqs. (2.18) and (3.2) to approximate the the kick factor by

$$\kappa_{\perp}^{rw} \cong 0.58 \frac{c Z_0}{4\pi} \frac{2 s_0 L}{b^4} \sqrt{\frac{s_0}{\sigma_s}} ,$$
(3.10)

and for the extreme anomalous skin effect, we use Eqs. (2.24) and (3.2) to show that

$$\kappa_{\perp}^{ease} \cong 0.21 \frac{c Z_0}{4\pi} \frac{2 s_a L}{b^4} \left(\frac{s_a}{\sigma_s}\right)^{2/3}.$$
(3.11)

When a Landau cavity is used, the synchrotron tune depends linearly on the oscillation amplitude. We define \bar{v}_s to be the synchrotron frequency of an electron with oscillation amplitude equal to the rms bunch length. From simulation, we find that a useful approximation to the threshold condition is

$$\frac{e^2 N_e \beta_y}{4\pi \gamma m c^2 \bar{\nu}_s} \kappa_{\perp} = 0.7, \qquad (3.12)$$

where the kick factor is evaluated using the appropriate electron distribution:

$$F(s) = N \exp(-\lambda s^4)$$
, where $N = \frac{2\lambda^{1/4}}{\Gamma(1/4)}$, and the rms bunch length $\Sigma_s^2 = \frac{\Gamma(3/4)}{\lambda^{1/2}\Gamma(1/4)}$.

The Landau cavity is operated under conditions such that $\bar{\nu}_s \ll \nu_s$ and $\Sigma_s \gg \sigma_s$. It follows from Eqs. (3.6) and (3.7) that

$$\kappa_{\perp}^{res} \cong 0.57 \frac{c R_{\perp}}{Q_{\perp}} (k_r^2 \Sigma_s)$$

$$(k_r \Sigma_s \ll 1) \qquad (3.13)$$

and

$$\kappa_{\perp}^{res} \cong 0.27 \frac{c}{\Sigma_s} \frac{R_{\perp}}{Q_{\perp}} \qquad (k_r \Sigma_s >> 1)$$
(3.14)

Hence, for a resonant wake field with $k_r \Sigma_s \ll 1$, we see from Eqs. (3.4), (3.8), (3.12) and (3.13) that the ratio of the threshold currents with and without the Landau cavity is

$$\frac{I_{th}^{Landau}}{I_{th}^{fund}} \cong \frac{\bar{v}_s}{v_s} \frac{\sigma_s}{\Sigma_s}.$$
 (3.15)

In this case the Landau cavity can greatly reduce the instability threshold. For a resonant wake with $k_r \sigma_s >> 1$, it follows from Eqs. (3.4), (3.9), (3.12) and (3.14) that

$$\frac{I_{th}^{Landau}}{I_{th}^{fund}} \cong \frac{\bar{v}_s}{v_s} \frac{\Sigma_s}{\sigma_s}.$$
 (3.16)

In this case the Landau cavity has only a small effect on the threshold current since the two factors in Eq. (3.13) approximately offset one another.

For a resistive wall wake, the kick factor with a Landau cavity is

$$\kappa_{\perp}^{rw} \cong 0.56 \frac{c Z_0}{4 \pi} \frac{2 s_0 L}{b^4} \sqrt{\frac{s_0}{\Sigma_s}} ,$$
(3.17)

and for the anomalous skin effect wake

$$\kappa_{\perp}^{ease} \cong 0.21 \frac{c Z_0}{4\pi} \frac{2 s_a L}{b^4} \left(\frac{s_a}{\Sigma_s}\right)^{2/3}.$$
(3.18)

It then follows that the ratio of the threshold currents with and without the Landau cavity is given by

$$\frac{I_{th}^{Landau}}{I_{th}^{fund}} \cong \frac{\bar{v_s}}{v_s} \left(\frac{\Sigma_s}{\sigma_s}\right)^p, \tag{3.19}$$

where

$$p = \begin{cases} 1/2 & \text{for resistive wall} \\ 2/3 & \text{for extreme anomalous skin effect} \end{cases}. \tag{3.20}$$

4. Illustrative Parameters for NSLS-II

Ring

$$E = 3GeV$$

$$T_0 = 2\mu s$$

$$\alpha = 1.7 \times 10^{-4}$$

$$N_{e} = 9.4 \times 10^{9}$$

$$I_e = eN_e / T_0 = 0.75 \, ma$$

$$\sigma_{\epsilon} = 10^{-3}$$

Fundamental rf

$$f_{rf} = 500MHz$$
 $(h = 1000)$

$$v_{s} = .004$$

$$\sigma_{\tau} = 12 \, ps$$
, $\sigma_{s} = 3.6 \, mm$

Insertion Device

$$\beta_{v} = 3m$$

$$L = 20 \times 5m$$

$$b = 2.5mm$$

warm chamber

$$\sigma = 6 \times 10^7 \left(ohm - m \right)^{-1}$$

$$s_0 = 8 \mu m$$

cold chamber

$$\sigma\ell ratio = 1.54 \times 10^{15} \left(ohm - m^2 \right)^{-1}$$

$$s_a=10\,\mu m$$

Broadband Resonator

$$R_{\perp} = 1.0 M\Omega / m$$

$$Q_{\perp} = 1$$

$$\omega_r = 2\pi \times 10^9 f_r (Ghz)$$

$$W_0^{res} = \frac{\omega_r R_\perp}{\sqrt{Q_\perp^2 - \frac{1}{4}}} = 1.1 \times 10^{16} f_r (GHz) \frac{\Omega}{m - s} \qquad Y^{res} = \frac{e^2 N_e \beta_y W_0^{res}}{8 \gamma mc^2 v_s} = 0.34 f_r (GHz)$$

Normal Resistive Wall

$$W_0^{rw} = \frac{cZ_0}{4\pi} \frac{2s_0L}{h^4} = 3.7 \times 10^{17} \frac{\Omega}{m-s}$$

Extreme Anomalous Skin Effect

$$W_0^{ease} = \frac{cZ_0}{4\pi} \frac{2s_a L}{h^4},$$

$$Y^{res} = \frac{e^2 N_e \beta_y W_0^{res}}{8 \gamma m c^2 v_s} = 0.34 f_r (GHz)$$

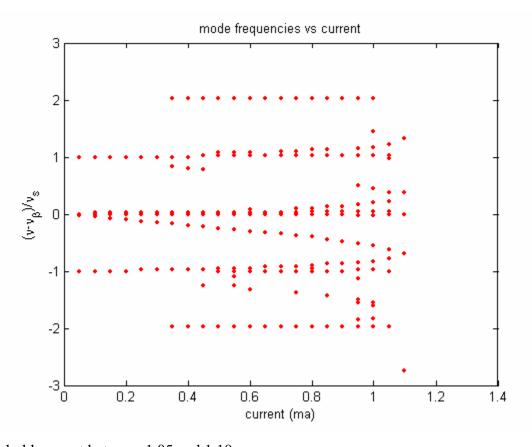
$$Y^{rw} = \frac{e^2 N_e \beta_y W_0^{rw}}{8 \gamma mc^2 v} = 17.4$$

$$Y^{ease} = \frac{e^2 N_e \beta_y W_0^{ease}}{8 \gamma mc^2 v_s} = 27.3$$

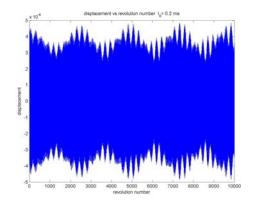
5. Simulation Results: Broad Band Resonance, Fundamental RF

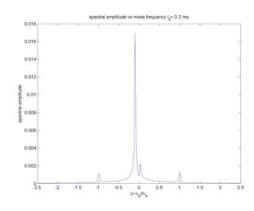
Resonator: $R_{\perp} = 1.0M\Omega/m$, $Q_{\perp} = 1$, $f_r = 10Ghz$

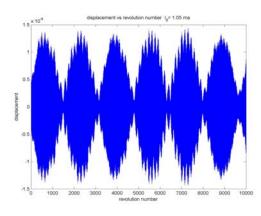
 $n_p = 100, \quad n_r = 10000$

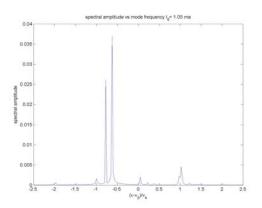


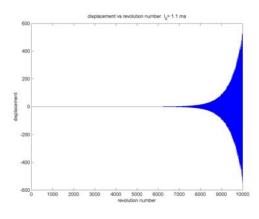
threshold current between 1.05 and 1.10 ma

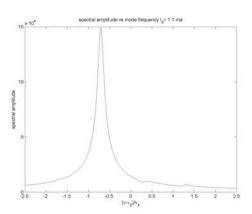




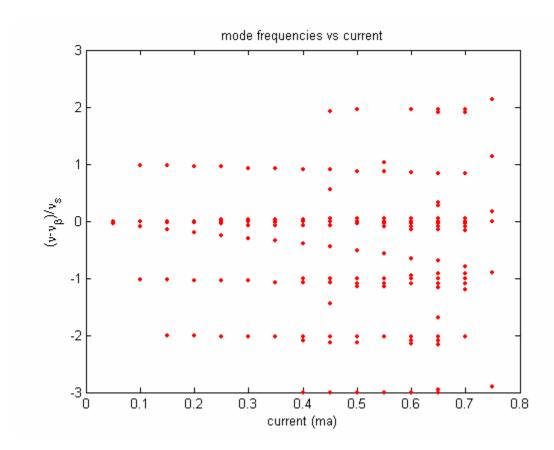






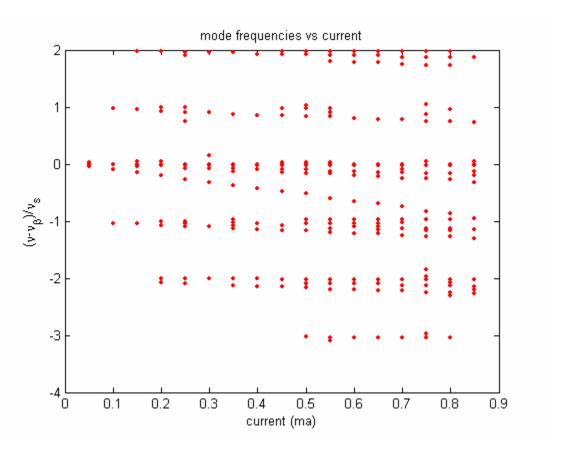


Resonator:
$$R_{\perp} = 1.0 M\Omega/m$$
, $Q_{\perp} = 1$, $f_r = 30 Ghz$ $n_p = 300$, $n_r = 10000$



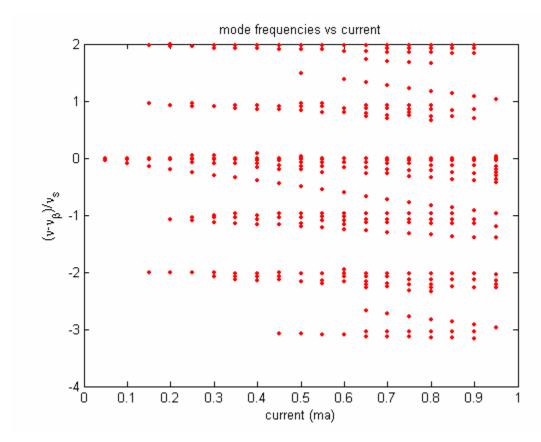
threshold current between 0.70 and 0.75 ma

Resonator:
$$R_{\perp} = 1.0 M\Omega/m$$
, $Q_{\perp} = 1$, $f_r = 50 Ghz$ $n_p = 500$, $n_r = 10000$



threshold current between 0.80 and 0.85 ma

Resonator: $R_{\perp} = 1.0 M\Omega/m$, $Q_{\perp} = 1$, $f_r = 100 Ghz$ $n_p = 1000$, $n_r = 10000$



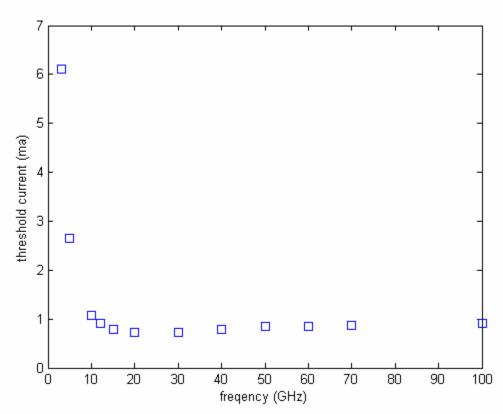
threshold current between 0.90 and 0.95 ma

Resonator: $R_{\perp} = 1.0 M\Omega / m$, $Q_{\perp} = 1$, $f_r(GHz)$

$$n_r = 10000, \quad n_p = 10 \times f_r (GHz)$$

$f_r(GHz)$	$I_{th}(ma)$
1	47
3	6.1
5	2.66
10	1.07
12	0.91
15	0.79
20	0.72
30	0.72
40	0.78
50	0.84
60	0.85
70	0.88

100 0.92 Minimum threshold current corresponds to $f_r \approx \frac{1}{\pi \sigma_r} = 26Ghz$.



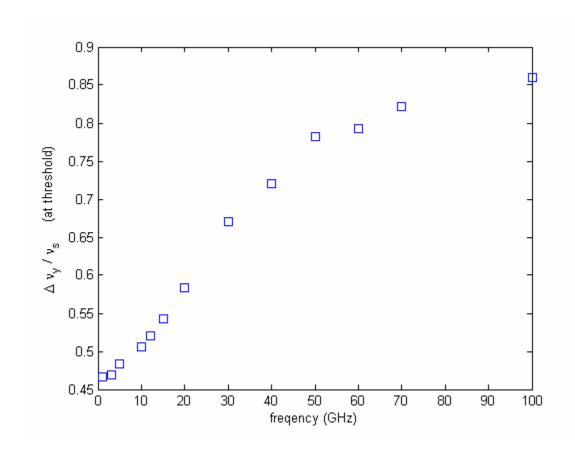
I have checked that in this case of a broadband resonator wake and the fundamental RF, my simulation results are in reasonable agreement with the frequency domain code MOSES [4].

$$\left(\frac{\Delta v_{y}}{v_{s}}\right)_{av}^{res} = \frac{2}{\pi} Y_{th} \frac{1}{2\pi \sigma_{s}^{2}} \int_{-\infty}^{\infty} ds \int_{-\infty}^{s} ds' e^{-s^{2}/2\sigma_{s}^{2}} e^{-s^{2}/2\sigma_{s}^{2}} f^{res}(s-s')$$

$$Y_{th}^{res} = \frac{e^{2} N_{e}^{th} \beta_{y}}{8 \gamma mc^{2} v_{s}} \frac{2\pi f_{r} R_{\perp}}{\sqrt{Q_{\perp}^{2} - \frac{1}{4}}} = 0.34 \frac{I_{th}(ma) f_{r}(GHz)}{0.75}$$

$$I_{th}(ma) = \frac{10.2}{f_{r}(GHz) h[0.024 \pi f_{r}(GHz)]}$$

$$h(k_{r} \sigma_{s}) = \int_{-\infty}^{\infty} dx \int_{-\infty}^{x} dy e^{-(x^{2} + y^{2})/2} \exp\left[-\frac{k_{r} \sigma_{s}}{2Q_{\perp}}(x - y)\right] \sin\left[k_{r} \sigma_{s} \sqrt{1 - \frac{1}{4Q_{\perp}^{2}}}(x - y)\right]$$



6. Simulation Results: Resistive Wall, Fundamental RF

Resistive Wall: $n_r = 10000$

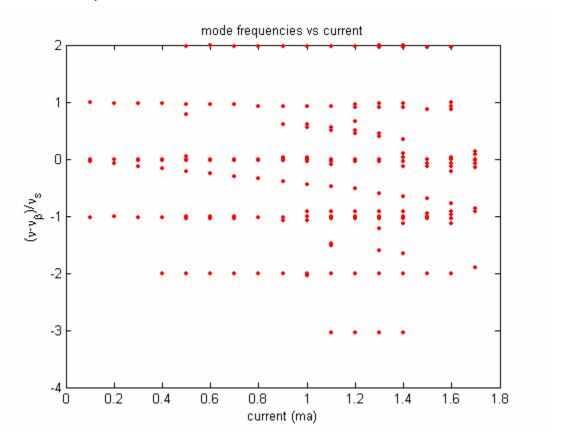
 $n_p I_{th}$

100 1.66 *ma*

200 1.70

400 1.71

Resistive wall: $n_p = 200$, $n_r = 10000$



$$\left(\frac{\Delta v_{y}}{v_{s}}\right)_{av} = \frac{2}{\pi} Y^{rw} \frac{1}{2\pi \sigma_{s}^{2}} \int_{-\infty}^{\infty} ds \int_{-\infty}^{s} ds' e^{-s^{2}/2\sigma_{s}^{2}} e^{-s^{2}/2\sigma_{s}^{2}} \sqrt{\frac{2s_{0}}{\pi (s-s')}}$$

$$= 0.37 Y^{rw} \sqrt{\frac{s_{0}}{\sigma_{s}}}$$

Threshold,
$$Y_{th}^{rw} = 17.4(1.7/.75) = 39.4$$
, corresponds to $\left(\frac{\Delta v_y}{v_s}\right)_{av} = 0.69$.

7. Simulation Results: Extreme Anomalous Skin Effect, Fundamental RF

Extreme Anomalous Skin Effect: $n_r = 10000$

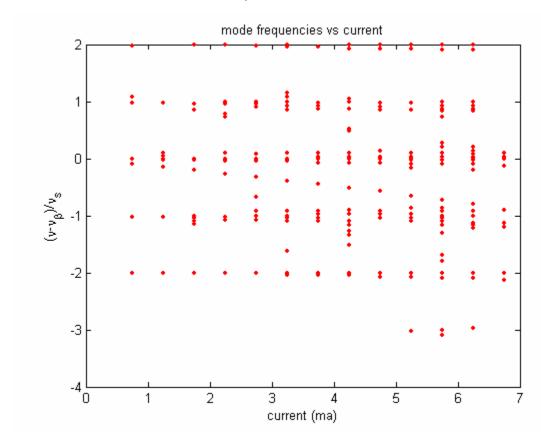
 $n_p I_{th}$

100 6.36

200 6.74

400 6.79

Extreme Anomalous Skin Effect: $n_p = 200$, $n_r = 10000$



$$\eta = \frac{4\sin^{5/3}(\pi/10)}{\Gamma(1/3)} = 0.210$$

$$\left(\frac{\Delta v_{y}}{v_{s}}\right)_{av} = \frac{2}{\pi} Y^{esa} \frac{1}{2\pi \sigma_{s}^{2}} \int_{-\infty}^{\infty} ds \int_{-\infty}^{s} ds' e^{-s^{2}/2\sigma_{s}^{2}} e^{-s^{2}/2\sigma_{s}^{2}} \eta \left(\frac{s_{a}}{s-s'}\right)^{2/3} = 0.13 Y^{ease} \left(\frac{s_{a}}{\sigma_{s}}\right)^{2/3}$$

Threshold,
$$Y_{th}^{ease} = 27.3(7.79/.75) = 247$$
, corresponds to $\left(\frac{\Delta v_y}{v_s}\right)_{av} = 0.64$.

8. Third-Harmonic (Landau) Cavity

Let us begin by reviewing the operation of a harmonic, bunch-lengthening cavity. The fundamental cavity operates at an angular frequency, $\omega_{rf} = h\omega_0$, where h is an integer and $\omega_0 = 2\pi/T_0$ is the angular frequency of revolution. Assuming the Landau cavity is operating at the n^{th} harmonic of the frequency of the fundamental RF, the voltage seen by an electron with temporal deviation τ is

$$V(\tau) = V_0 \left[\sin(\omega_{rf} \tau + \phi_s) + \kappa \sin(n\omega_{rf} + \phi_n) \right]. \tag{8.1}$$

In the ideal operation of such a cavity, one chooses to satisfy the conditions

$$U_0 = V_0 \left[\sin \phi_s + \kappa \sin \phi_n \right]$$

$$0 = \cos \phi_s + n\kappa \cos \phi_n$$

$$0 = \sin \phi_s + n\kappa \sin \phi_n.$$
(8.2)

In this case, the voltage has the form

$$V(\tau) = \cos\phi_s \left(\sin\omega_{rf}\tau - \frac{1}{n}\sin n\omega_{rf}\tau\right) + \sin\phi_s \left(\cos\omega_{rf}\tau - \frac{1}{n^2}\cos n\omega_{rf}\tau\right). \tag{8.3}$$

Approximating this for small τ yields the cubic form

$$V(\tau) \cong \cos \phi_s \left(\frac{n^2 - 1}{6}\right) \left(\omega_{rf} \tau\right)^3 + \sin \phi_s \left(1 - \frac{1}{n^2}\right). \tag{8.4}$$

The equations of motion become

$$\dot{\tau} = -\alpha \varepsilon$$

$$\dot{\varepsilon} = \frac{eV_0 \cos \phi_s}{E_0 T_0} \left(\frac{n^2 - 1}{6} \right) (h\omega_0 \tau)^3.$$
(8.5)

Together, these two equations imply

$$\tau + \rho \tau = 0. \tag{8.6}$$

where

$$\rho = v_{ref}^2 h^2 \left(\frac{n^2 - 1}{6} \right) \omega_0^4 \tag{8.7}$$

and

$$v_{ref}^2 \equiv \frac{h\alpha eV_0 \cos\phi_s}{2\pi E_0} \,. \tag{8.8}$$

The solution to Eq. (8.6) can be written in terms of an elliptic function of modulus ½,

$$\tau(t) = r \operatorname{cn}\left(\sqrt{\rho} r t; k^2 = 1/2\right). \tag{8.9}$$

The synchrotron frequency has a linear dependence on the oscillation amplitude r,

$$\omega_s = \frac{\pi}{2K} \sqrt{\rho} \, r \,, \tag{8.10}$$

where the elliptic integral $K = K(k^2 = 1/2) = \frac{\sqrt{2\pi} \Gamma(1/4)}{4\Gamma(3/4)} = 1.85$.

The equilibrium distribution determined by radiation damping and quantum

fluctuations is proportional to $\exp\left[-\frac{1}{\sigma_{\varepsilon}^{2}}\left(\frac{\varepsilon^{2}}{2} + \frac{\rho \tau^{4}}{4\alpha^{2}}\right)\right]$, and the rms bunch duration Σ_{t}

is given by

$$\Sigma_t^2 = \frac{\Gamma(3/4)}{\Gamma(1/4)} \frac{2\alpha \,\sigma_{\varepsilon}}{\sqrt{\rho}} \,. \tag{8.11}$$

It is useful to define \bar{v}_s to be the synchrotron tune corresponding to a synchrotron oscillation amplitude equal to the rms bunch duration, Σ_t , i.e.

$$\bar{v}_s \equiv \frac{\pi}{2K} \sqrt{\frac{\rho}{\omega_0^2}} \Sigma_t. \tag{8.12}$$

Then one can write

$$\bar{v}_s \, \omega_0 \, \Sigma_t = \left(\frac{\pi}{2}\right)^{3/2} \frac{\alpha}{K^2} \, \sigma_{\varepsilon} \,. \tag{8.13}$$

For NSLS-II parameters:

h	1000
n	3
V_{ref}	0.004
ρ	$2.1 \times 10^{27} \text{ sec}^{-4}$
\sum_{t} / \sum_{s}	50 ps / 15 mm
$\overset{-}{\mathcal{V}}_{s}$	0.0006

In order to carry out simulations to study the transverse instabilities with a third-harmonic Landau cavity, we use Eqs.(2.5-2.10) and replace Eq. (2.4) by

$$\varepsilon_{i+1}(j,k) = \varepsilon_i(j,k) + \frac{b}{\alpha T_0^3} \tau_i(j,k)^3 , \qquad (2.4a)$$

where

$$b = \rho T_0^4 = \left[\frac{2\Gamma(3/4)\alpha \,\sigma_{\varepsilon} \,T_0^2}{\Gamma(1/4)\Sigma_t^2} \right]^2. \tag{8.14}$$

The initial conditions for the transverse motion are determined in the same manner as for the case when there is only the fundamental RF cavity. However, in order to determine initial conditions for the longitudinal motion, we carry out a short simulation to obtain a thermal distribution. In order to accomplish this, we use the equations of motion:

$$\varepsilon_{n+1} = \varepsilon_n + \frac{b\tau_n^3}{\alpha T_0^3} - a\varepsilon_n - u_n$$

$$\tau_{n+1} = \tau_n - \alpha T_0 \varepsilon_{n+1}$$
(8.15)

Here, a is the inverse damping time and u_n is Gaussian random variable with standard deviation

$$\sigma_u = \sqrt{2a} \,\sigma_{\varepsilon}. \tag{8.16}$$

We start this simulation with ε_n , τ_n distributed according to a Gaussian distribution. The final equilibrium values are very insensitive to the starting values. We then use the final values as initial conditions for the simulation of the transverse instabilities with a Landau cavity.

9. Simulation Results: Broad Band Resonance, Landau Cavity

Resonator: $R_{\perp} = 1.0 M\Omega/m$, $Q_{\perp} = 1$, $n_r = 40000$

$f_r(GHz)$	$\underline{I_{th}(ma)}$	$\underline{n}_{\underline{p}}$
1	1.95	200
	1.95	400
2	0.80-0.85	100
	0.70-0.75	200
	0.70-0.75	400
3	0.50-0.60	100
	0.45	200
	0.45-0.50	400
5	0.40-0.45	100
	0.30-0.35	200
	0.30-0.40	400
7	0.6-0.7	100
	0.5-0.6	200
	0.5-0.6	400
10	0.8-1.0	100
	0.7-0.8	200
	0.7-0.8	400

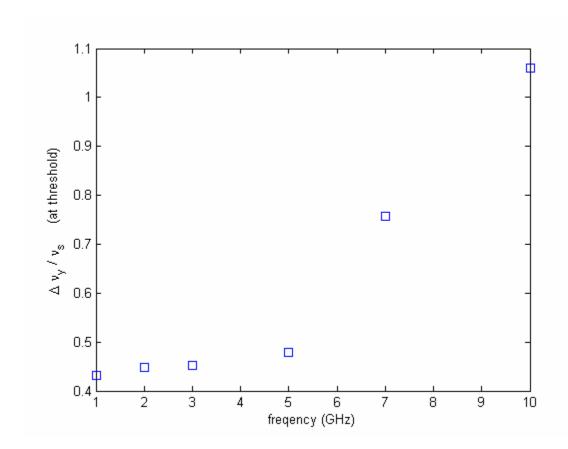
complicated behavior observed, slow growth rate near threshold, sometimes stable region found at higher current than first observation of instability,

$$\hat{N} = \frac{2\lambda^{1/4}}{\Gamma(1/4)} \qquad \Sigma_s^2 = \frac{\Gamma(3/4)}{\lambda^{1/2} \Gamma(1/4)} \qquad \lambda = \frac{\rho}{4\alpha^2 \sigma_{\varepsilon}^2 c^4}$$

$$\left(\frac{\Delta v_{y}}{v_{s}}\right)_{av} = \left(\frac{2}{\pi}\right) Y_{ref}^{rw} \frac{v_{s}^{ref}}{v_{s}} \bigwedge^{2} \int_{-\infty}^{\infty} ds \int_{-\infty}^{s} ds' e^{-\lambda (s^{4} + s'^{4})} f^{res}(s - s')$$

$$= \left(\frac{2}{\pi}\right) Y_{ref}^{rw} \frac{v_{s}^{ref}}{v_{s}} \frac{4}{\Gamma^{2}(1/4)} h(k \lambda^{-1/4})$$

$$h(\kappa) = \int_{-\infty}^{\infty} dx \int_{-\infty}^{x} dy \, e^{-\left(x^4 + y^4\right)} \exp\left[-\frac{\kappa}{2Q_{\perp}}(x - y)\right] \sin\left[\kappa \sqrt{1 - \frac{1}{4Q_{\perp}^2}}(x - y)\right]$$



10. Simulation Results: Resistive Wall, Landau Cavity

Resistive Wall: $n_r = 40000$

$$n_p I_{th}$$

$$\hat{N} = \frac{2\lambda^{1/4}}{\Gamma(1/4)} \qquad \Sigma_s^2 = \frac{\Gamma(3/4)}{\lambda^{1/2} \Gamma(1/4)} \qquad \lambda = \frac{\rho}{4\alpha^2 \sigma_s^2 c^4}$$

$$\left(\frac{\Delta v_{y}}{\bar{v}_{s}}\right)_{av} = \left(\frac{2}{\pi}\right) Y_{ref}^{rw} \frac{v_{s}^{ref}}{\bar{v}_{s}} \hat{N}^{2} \int_{-\infty}^{\infty} ds \int_{-\infty}^{s} ds' e^{-\lambda \left(s^{4} + s'^{4}\right)} \sqrt{\frac{2s_{0}}{\pi \left(s - s'\right)}}$$

$$= \left(\frac{2}{\pi}\right) Y_{ref}^{rw} \frac{v_{s}^{ref}}{\bar{v}_{s}} \left(\hat{N} \lambda^{-1/4}\right)^{2} \sqrt{\frac{2s_{0}}{\pi \lambda^{-1/4}}} (3.05)$$

$$= \left(\frac{2}{\pi}\right) Y_{ref}^{rw} \frac{v_{s}^{ref}}{\bar{v}_{s}} \frac{4}{\Gamma^{2} (1/4)} \left[\frac{\Gamma(3/4)}{\Gamma(1/4)}\right]^{1/4} \sqrt{\frac{2s_{0}}{\pi \Sigma_{s}}} (3.05)$$

$$= 0.36 Y_{ref}^{rw} \frac{v_{s}^{ref}}{\bar{v}_{s}} \sqrt{\frac{s_{0}}{\Sigma_{s}}}$$

Threshold,
$$Y_{ref,th}^{rw} = 17.4 \frac{0.46}{0.75} = 10.7$$
, corresponds to $\left(\frac{\Delta v_y}{v_s}\right)_{av} = 0.59$.

11. Simulation Results: Extreme Anomalous Skin Effect, Landau Cavity

Extreme Anomalous Skin Effect: $n_r = 40000$

$$n_p I_{th}$$

$$\hat{N} = \frac{2\lambda^{1/4}}{\Gamma(1/4)} \qquad \Sigma_s^2 = \frac{\Gamma(3/4)}{\lambda^{1/2} \Gamma(1/4)} \qquad \lambda = \frac{\rho}{4\alpha^2 \sigma_s^2 c^4}$$

$$\left(\frac{\Delta v_{y}}{\bar{v}_{s}}\right)_{av} = \left(\frac{2}{\pi}\right) Y_{ref}^{ease} \frac{V_{s}^{ref}}{\bar{v}_{s}} N^{2} \int_{-\infty}^{\infty} ds \int_{-\infty}^{s} ds' e^{-\lambda(s^{4}+s^{*4})} \eta \left(\frac{s_{a}}{s-s'}\right)^{2/3}$$

$$= \left(\frac{2}{\pi}\right) Y_{ref}^{ease} \frac{V_{s}^{ref}}{\bar{v}_{s}} \left(N \lambda^{-1/4}\right)^{2} \left(\frac{s_{a}}{\lambda^{-1/4}}\right)^{2/3} \eta \left(4.52\right)$$

$$= \left(\frac{2}{\pi}\right) Y_{ref}^{ease} \frac{V_{s}^{ref}}{\bar{v}_{s}} \frac{4}{\Gamma^{2} (1/4)} \left[\frac{\Gamma(3/4)}{\Gamma(1/4)}\right]^{1/3} \left(\frac{s_{a}}{\lambda^{-1/4}}\right)^{2/3} \eta \left(4.52\right)$$

$$= 0.13 Y_{ref}^{ease} \frac{V_{s}^{ref}}{\bar{v}_{s}} \left(\frac{s_{a}}{\Sigma_{s}}\right)^{2/3}$$

Threshold,
$$Y_{ref,th}^{ease} = 27.3 \frac{2.4}{0.75} = 87$$
, corresponds to $\left(\frac{\Delta v_y}{v_s}\right)_{av} = 0.58$.

12. Summary of Results

We summarize the results obtained using the NSLS-II parameters as given in Section 4. Threshold currents for different parameters can be estimated using the scaling relations (3.4) and (3.12).

Fundamental RF

Synchrotron Tune $v_s = .004$

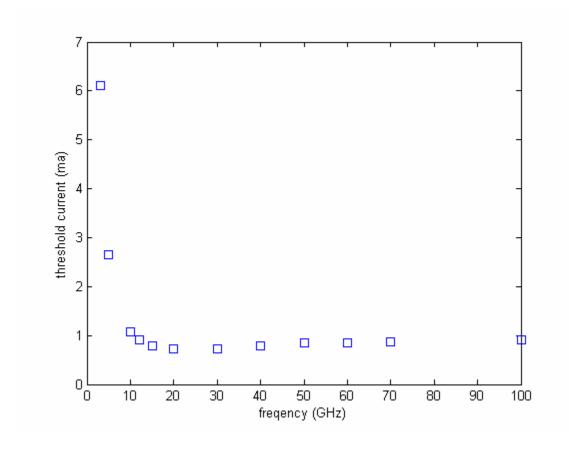
Bunch length $\sigma_s = 3.6mm$

Vertical betafunction $\beta_y = 3m$

Resistive wall (100m of room temperature copper, b = 2.5mm) $I_{th}(ma) = 1.7ma$

Extreme Anomalous Skin Effect $I_{th}(ma) = 6.8ma$

Broad-Band Resonator $R_{\perp} = 1M\Omega/m$, $Q_{\perp} = 1$



Landau Cavity

Average Synchrotron Tune $\bar{v}_s = .0006$

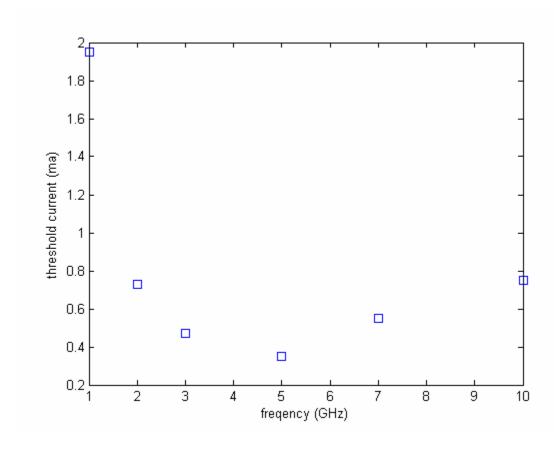
Bunch length $\Sigma_s = 15mm$

Vertical betafunction $\beta_y = 3m$

Resistive wall (100m of room temperature copper, b = 2.5mm) $I_{th}(ma) = 0.46ma$

Extreme Anomalous Skin Effect $I_{th}(ma) = 2.4ma$

Broad-Band Resonator $R_{\perp} = 1M\Omega/m$, $Q_{\perp} = 1$



13. Concluding Remarks

In this note, we have described a computer simulation program written with MATLAB. Using this program, we have carried out studies of the TMCI single bunch instability for NSLS-II, in the case of vanishing chromaticity. In the future, we plan to investigate the stabilizing effect of positive chromaticity. We also plan to include the effect of wakefields coupling the center of mass motion of different bunches.

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